

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/785,080	IKEDA ET AL.	
Examiner	Art Unit	
Deborah Yee	1742	

SEARCHED				
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Class	Subclass	Date	Examiner	
148	320 333-336 660-663 654,648	7/27/2007	/DY/	
148	649			
420	8			
420	104-112	4		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
420	8	7/1/2707	/DY/	
420	104-112			
148/320,333-336,660- 663,654,648,649			+	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
west and inventorship search	7/27/2007	/DY/		